

N-Channel 75-V (D-S) MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)
75	0.007 at V _{GS} = 10 V	110 ^d	69

FEATURES

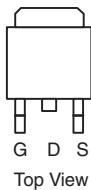
- TrenchFET® Power MOSFETs
- 100 % R_g and UIS Tested



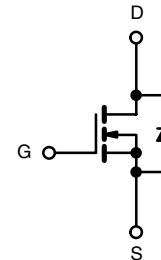
APPLICATIONS

- Synchronous Rectification

TO-263



Top View



Ordering Information: SUM110N08-07P-E3 (Lead (Pb)-free)

N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T_C = 25 °C, unless otherwise noted

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	75	V
Gate-Source Voltage	V _{GS}	± 20	
Continuous Drain Current (T _J = 150 °C)	I _D	110 ^d	A
		103	
Pulsed Drain Current	I _{DM}	180	
Avalanche Current	I _{AS}	50	
Single Avalanche Energy ^a	E _{AS}	125	mJ
Maximum Power Dissipation ^a	P _D	208.3 ^b	W
		3.75	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Limit	Unit
Junction-to-Ambient (PCB Mount) ^c	R _{thJA}	40	°C/W
Junction-to-Case (Drain)	R _{thJC}	0.6	

Notes:

- a. Duty cycle ≤ 1 %.
- b. See SOA curve for voltage derating.
- c. When Mounted on 1" square PCB (FR-4 material).
- d. Package limited.

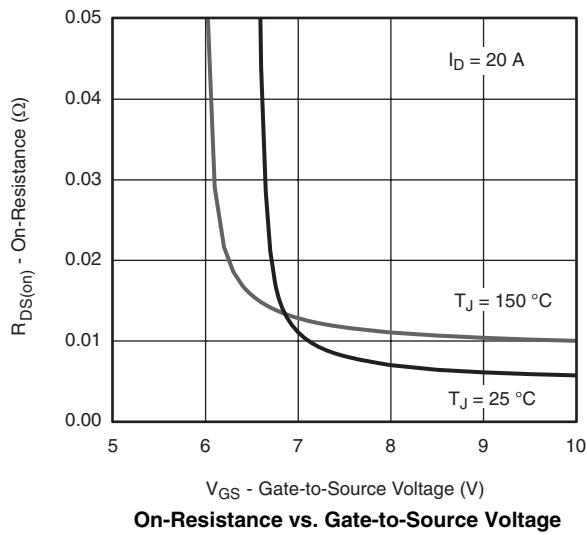
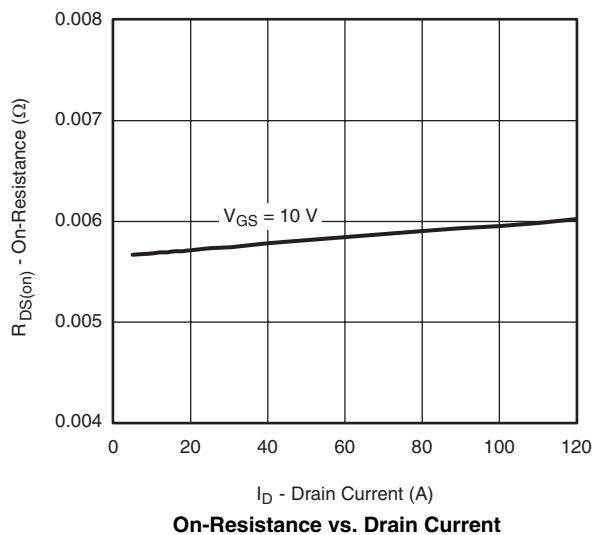
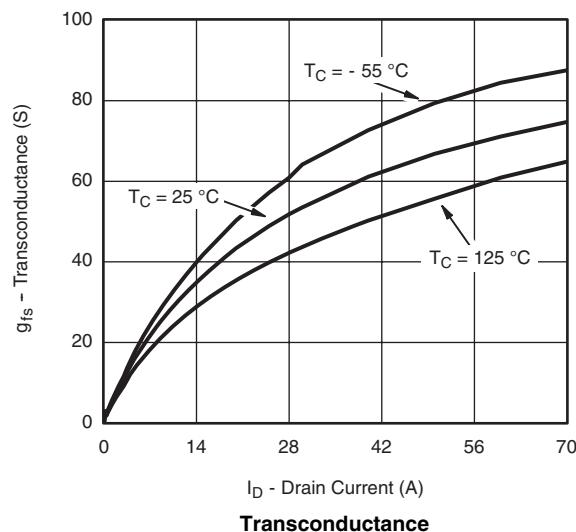
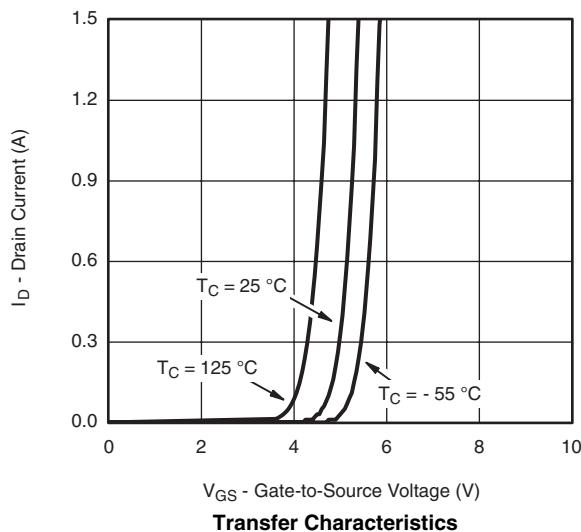
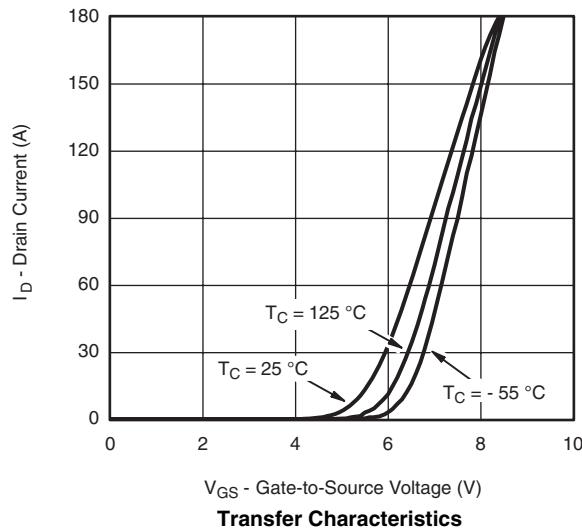
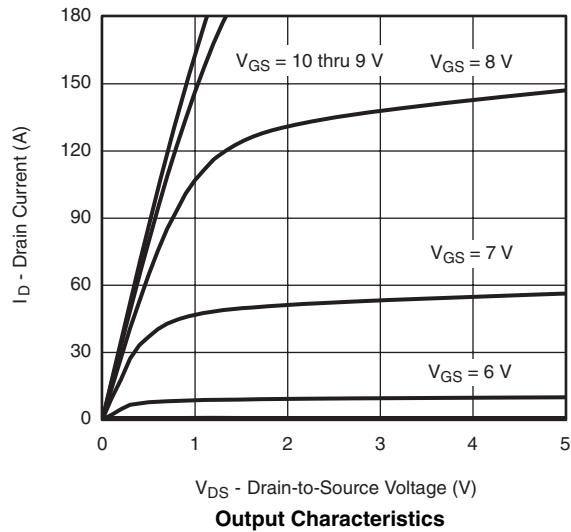
SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{DS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	75			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	2.5		4.5	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 250	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
		$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125^\circ\text{C}$			50	
		$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 150^\circ\text{C}$			250	
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{DS} \geq 10 \text{ V}, V_{GS} = 10 \text{ V}$	70			A
Drain-Source On-State Resistance ^a	$R_{DS(\text{on})}$	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		0.0057	0.007	Ω
		$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125^\circ\text{C}$		0.0092	0.0112	
Forward Transconductance ^a	g_{fs}	$V_{DS} = 15 \text{ V}, I_D = 20 \text{ A}$		43		S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$		4250		pF
Output Capacitance	C_{oss}			580		
Reverse Transfer Capacitance	C_{rss}			230		
Total Gate Charge ^c	Q_g	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$		69	105	nC
Gate-Source Charge ^c	Q_{gs}			23		
Gate-Drain Charge ^c	Q_{gd}			21		
Gate Resistance	R_g	$f = 1 \text{ MHz}$		1.2	2.4	Ω
Turn-On Delay Time ^c	$t_{d(\text{on})}$	$V_{DD} = 30 \text{ V}, R_L = 0.6 \Omega$ $I_D \geq 50 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		17	30	ns
Rise Time ^c	t_r			5	10	
Turn-Off Delay Time ^c	$t_{d(\text{off})}$			22	40	
Fall Time ^c	t_f			6	15	
Source-Drain Diode Ratings and Characteristics $T_C = 25^\circ\text{C}^b$						
Continuous Current	I_S				110	A
Pulsed Current	I_{SM}				180	
Forward Voltage ^a	V_{SD}	$I_F = 20 \text{ A}, V_{GS} = 0 \text{ V}$		0.83	1.5	V
Reverse Recovery Time	t_{rr}	$I_F = 75 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}$		65	100	ns
Peak Reverse Recovery Current	$I_{RM(\text{REC})}$			2.5	5	A
Reverse Recovery Charge	Q_{rr}			85	150	nC

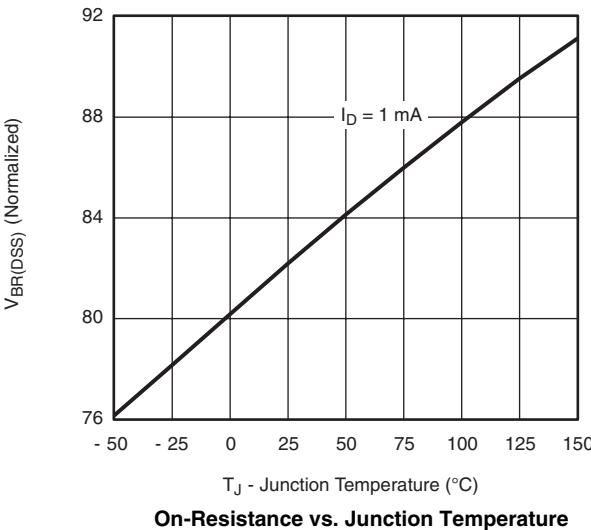
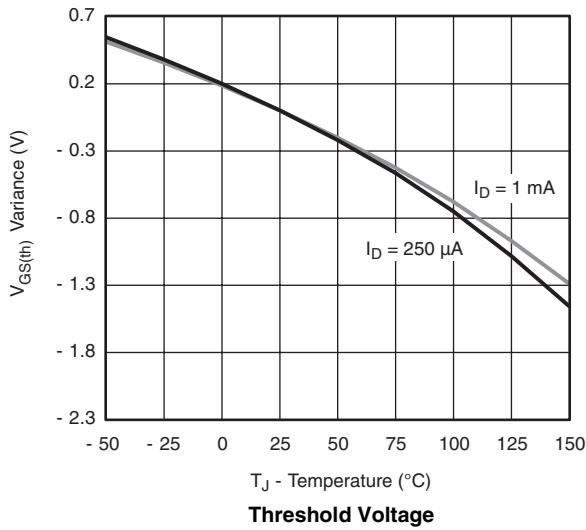
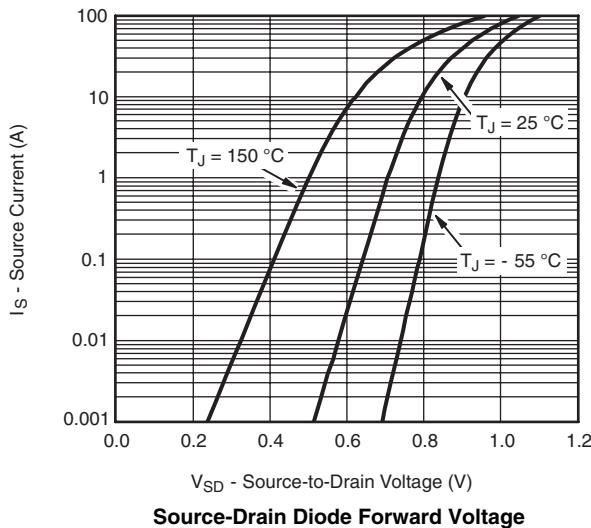
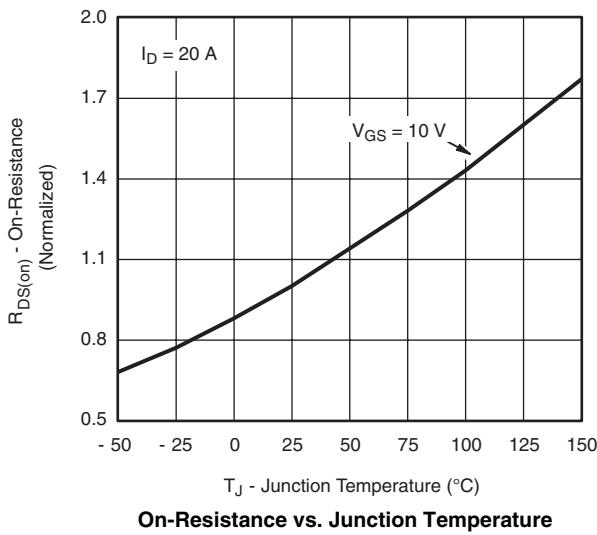
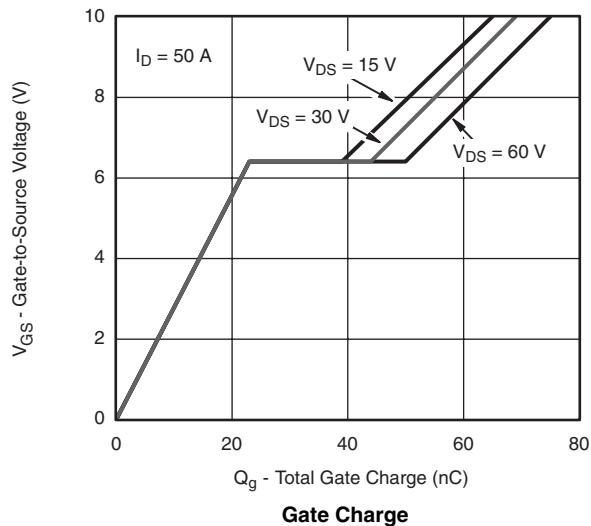
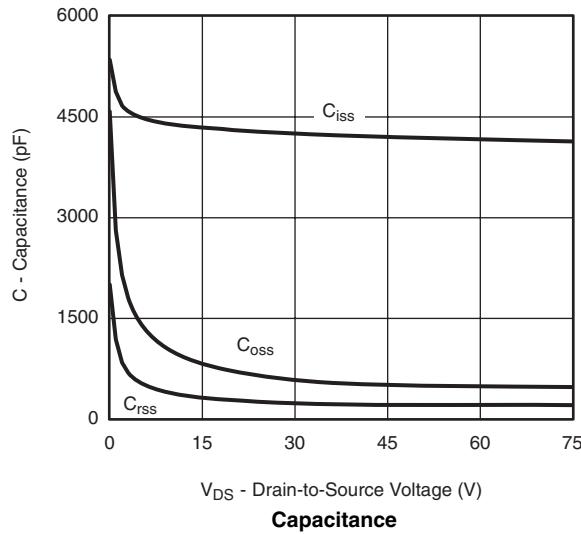
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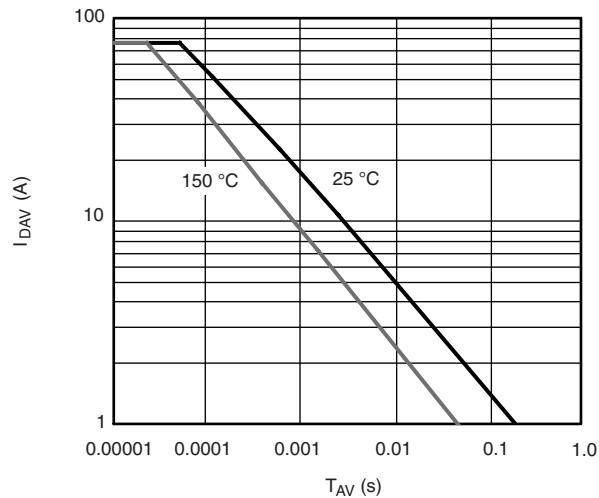
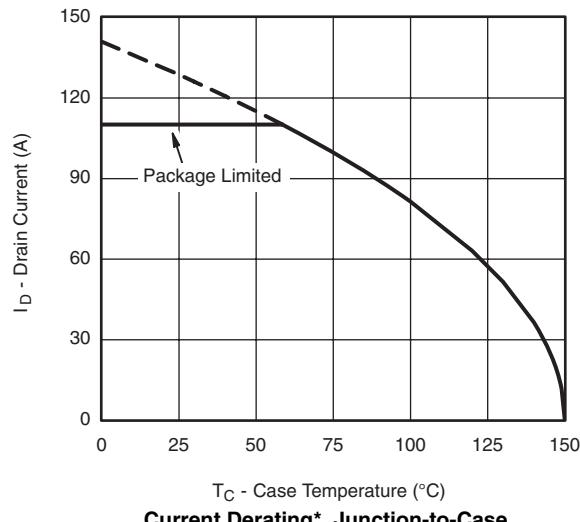
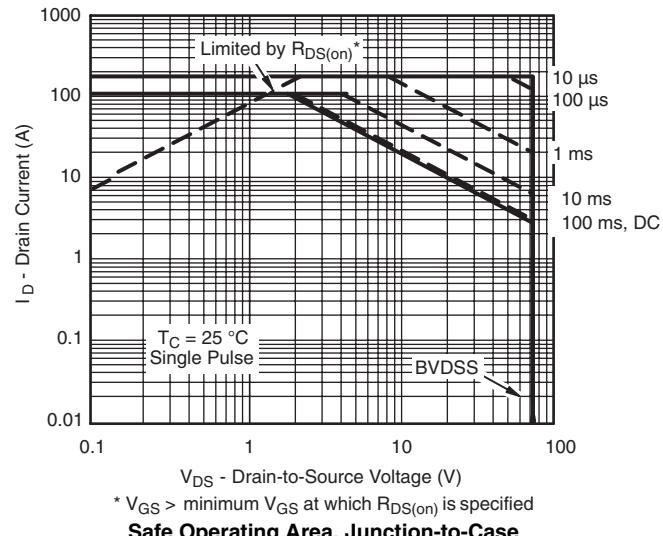
- a. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

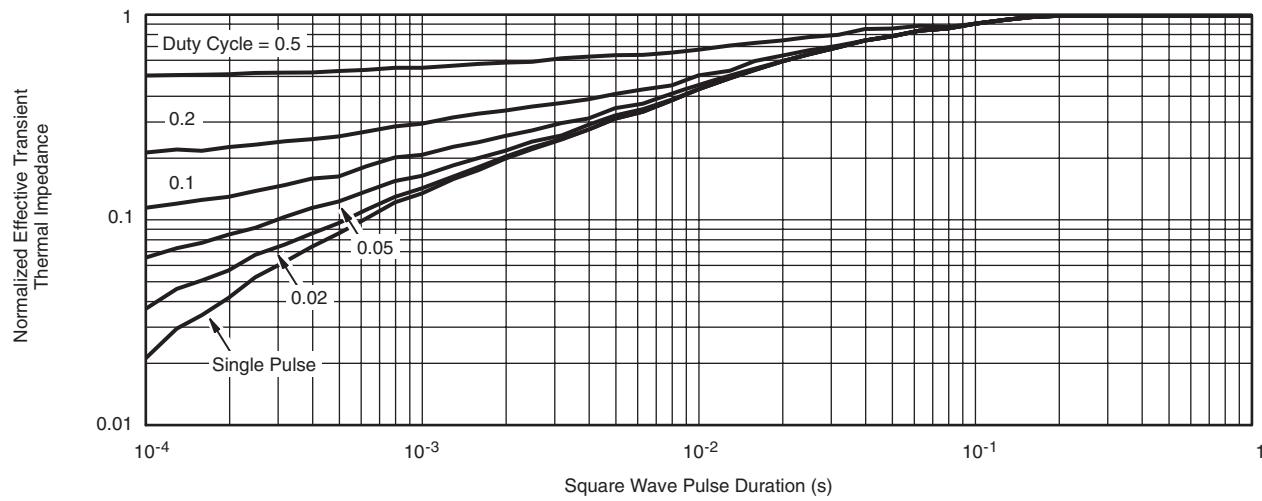
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


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Single Pulse Avalanche Current Capability vs. Time

Current Derating*, Junction-to-Case

* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.


Normalized Thermal Transient Impedance, Junction-to-Case

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